# International Rectifier

### **Applications**

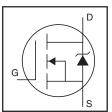
- High Efficiency Synchronous Rectification in SMPS
- Uninterruptible Power Supply
- High Speed Power Switching
- Hard Switched and High Frequency Circuits

### **Benefits**

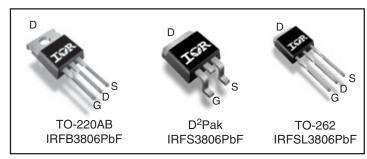
- Improved Gate, Avalanche and Dynamic dv/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dl/dt Capability

# IRFB3806PbF IRFSL3806PbF

HEXFET® Power MOSFET



V <sub>DSS</sub>		60V
R <sub>DS(on)</sub>	typ.	12.6m $Ω$
	max.	15.8m $Ω$
I <sub>D</sub>		43A



G	D	S
Gate	Drain	Source

### **Absolute Maximum Ratings**

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, VGS @ 10V	43	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	31	Α
I <sub>DM</sub>	Pulsed Drain Current ①	170	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	71	W
	Linear Derating Factor	0.47	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
dv/dt	Peak Diode Recovery ③	24	V/ns
T <sub>J</sub>	Operating Junction and	-55 to + 175	°C
$T_{STG}$	Storage Temperature Range		
	Soldering Temperature, for 10 seconds	300	
	(1.6mm from case)		
	Mounting torque, 6-32 or M3 screw	10lb·in (1.1N·m)	

### **Avalanche Characteristics**

E <sub>AS (Thermally limited)</sub>	Single Pulse Avalanche Energy ②	73	mJ
I <sub>AR</sub>	Avalanche Current ①	25	Α
E <sub>ΔR</sub>	Repetitive Avalanche Energy 4	7.1	mJ

### **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ®		2.12	
$R_{\theta CS}$	Case-to-Sink, Flat Greased Surface, TO-220	0.50		°C/W
$R_{\theta JA}$	Junction-to-Ambient, TO-220 ⑦®		62	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount), D <sup>2</sup> Pak ⑦®		40	

### Static @ $T_J = 25^{\circ}C$ (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	60			٧	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.075		V/°C	Reference to 25°C, I <sub>D</sub> = 5mA <sup>①</sup>
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		12.6	15.8	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 25A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}$ , $I_D = 50\mu A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20	μΑ	$V_{DS} = 60V$ , $V_{GS} = 0V$
				250		$V_{DS} = 48V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	nΑ	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage			-100		$V_{GS} = -20V$

## Dynamic @ T<sub>J</sub> = 25°C (unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
gfs	Forward Transconductance	41			S	$V_{DS} = 10V, I_{D} = 25A$
$Q_g$	Total Gate Charge		22	30	nC	I <sub>D</sub> = 25A
$Q_{gs}$	Gate-to-Source Charge		5.0			$V_{DS} = 30V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		6.3			V <sub>GS</sub> = 10V ⊕
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		28.3			$I_D = 25A, V_{DS} = 0V, V_{GS} = 10V$
$R_{G(int)}$	Internal Gate Resistance		0.79		Ω	
$t_{d(on)}$	Turn-On Delay Time		6.3		ns	$V_{DD} = 39V$
t <sub>r</sub>	Rise Time		40			$I_D = 25A$
$t_{\text{d(off)}} \\$	Turn-Off Delay Time		49			$R_G = 20\Omega$
t <sub>f</sub>	Fall Time		47			V <sub>GS</sub> = 10V ⊕
C <sub>iss</sub>	Input Capacitance		1150			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		130			$V_{DS} = 50V$
C <sub>rss</sub>	Reverse Transfer Capacitance		67		рF	f = 1.0MHz
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)@		190			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 60V $
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related)®		230			$V_{GS} = 0V$ , $V_{DS} = 0V$ to $60V$

### **Diode Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			43	Α	MOSFET symbol
	(Body Diode)					showing the
I <sub>SM</sub>	Pulsed Source Current			170		integral reverse
	(Body Diode) ①					p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	٧	$T_J = 25^{\circ}C$ , $I_S = 25A$ , $V_{GS} = 0V$ ④
t <sub>rr</sub>	Reverse Recovery Time		22	33	ns	$T_J = 25^{\circ}C$ $V_R = 51V$ ,
			26	39		$T_J = 125^{\circ}C$ $I_F = 25A$
$Q_{rr}$	Reverse Recovery Charge		17	26	nC	$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s ④
			24	36		$T_J = 125^{\circ}C$
I <sub>RRM</sub>	Reverse Recovery Current		1.4		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrins	ic turn-	on time	is negl	igible (turn-on is dominated by LS+LD)

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J$  = 25°C, L = 0.23mH  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = 25A,  $V_{GS}$  =10V. Part not recommended for use above this value.
- $\label{eq:local_loss} \ensuremath{ \Im \ I_{SD}} \leq 25A, \ di/dt \leq 1580A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^\circ C.$
- 4 Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .

- $^{\circ}$  C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- $\ensuremath{\$}\ \ensuremath{\mathsf{R}}_{\theta}$  is measured at T\_J approximately 90°C.

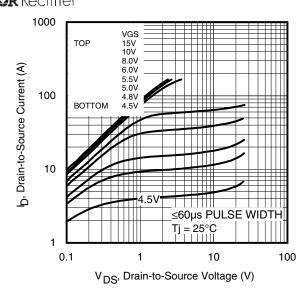


Fig 1. Typical Output Characteristics

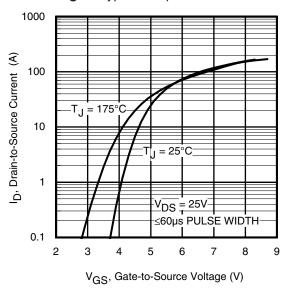
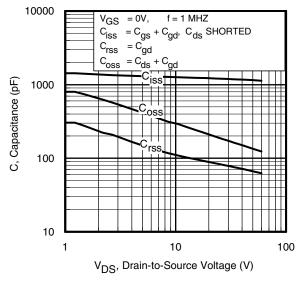


Fig 3. Typical Transfer Characteristics



**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage www.irf.com

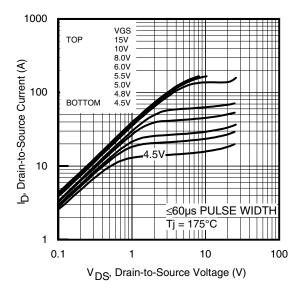


Fig 2. Typical Output Characteristics

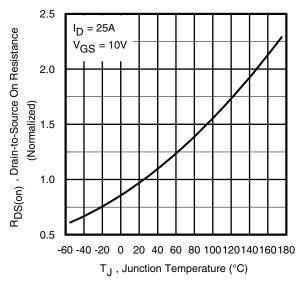


Fig 4. Normalized On-Resistance vs. Temperature

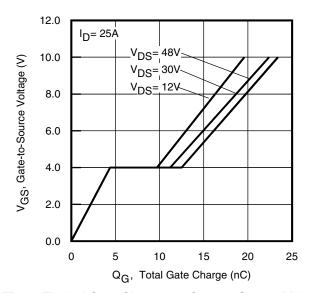


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

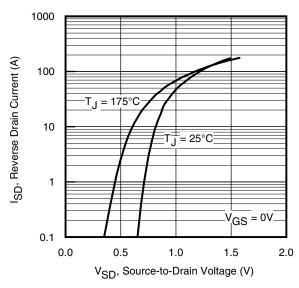


Fig 7. Typical Source-Drain Diode Forward Voltage

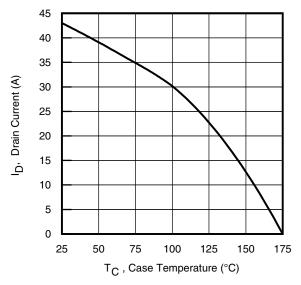


Fig 9. Maximum Drain Current vs. Case Temperature

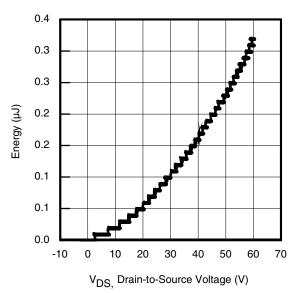


Fig 11. Typical C<sub>OSS</sub> Stored Energy

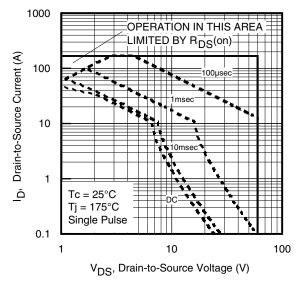


Fig 8. Maximum Safe Operating Area

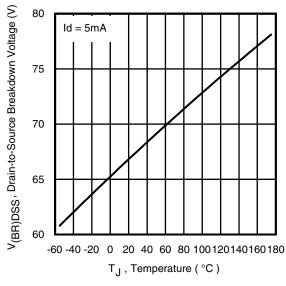


Fig 10. Drain-to-Source Breakdown Voltage

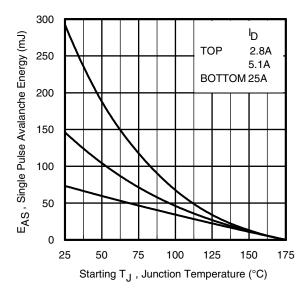


Fig 12. Maximum Avalanche Energy vs. DrainCurrent www.irf.com

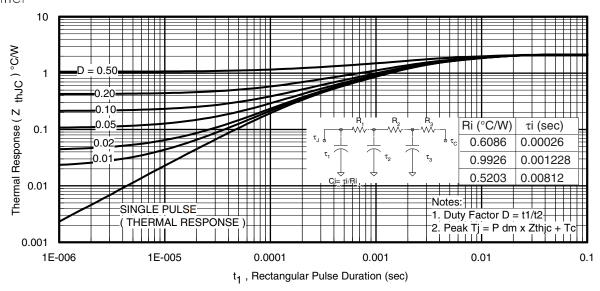


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

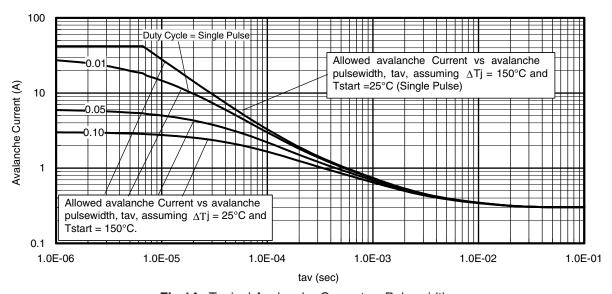


Fig 14. Typical Avalanche Current vs.Pulsewidth

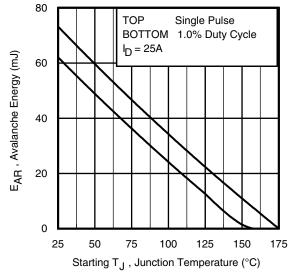


Fig 15. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves, Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT<sub>imax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 16a, 16b.
- 4. P<sub>D (ave)</sub> = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

t<sub>av</sub> = Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

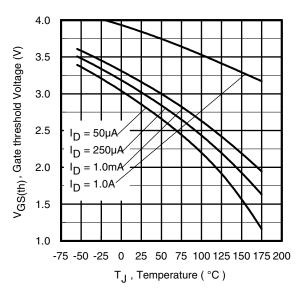


Fig 16. Threshold Voltage vs. Temperature

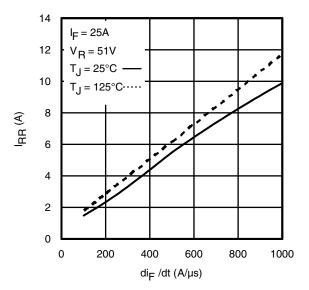


Fig. 18 - Typical Recovery Current vs. dif/dt

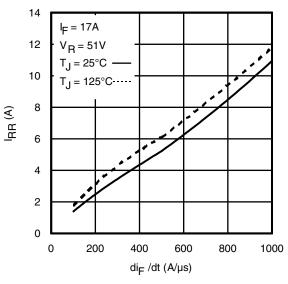


Fig. 17 - Typical Recovery Current vs. di<sub>f</sub>/dt

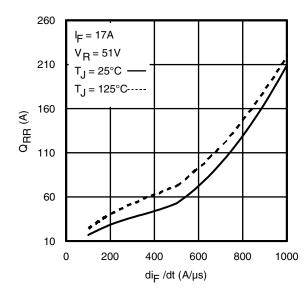


Fig. 19 - Typical Stored Charge vs. dif/dt

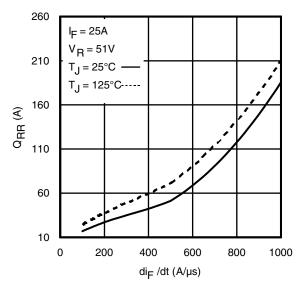


Fig. 20 - Typical Stored Charge vs. dif/dt

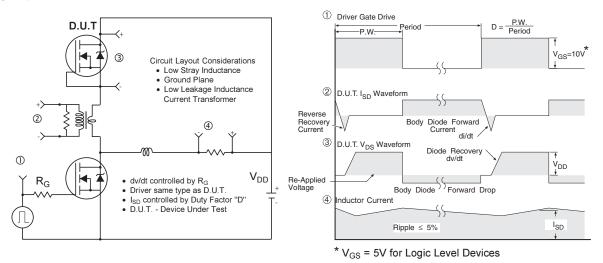


Fig 20. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

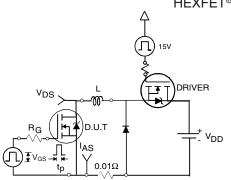


Fig 21a. Unclamped Inductive Test Circuit

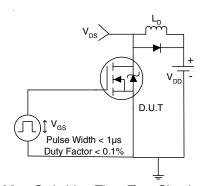


Fig 22a. Switching Time Test Circuit

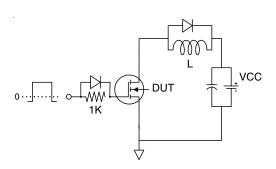


Fig 23a. Gate Charge Test Circuit

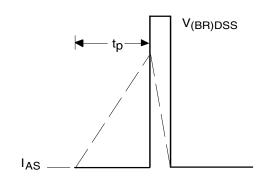


Fig 21b. Unclamped Inductive Waveforms

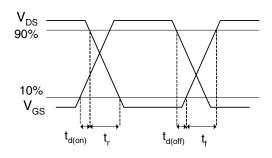


Fig 22b. Switching Time Waveforms

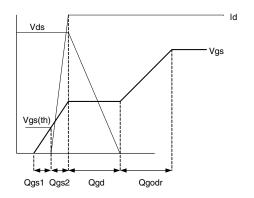
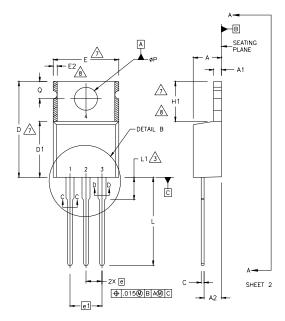
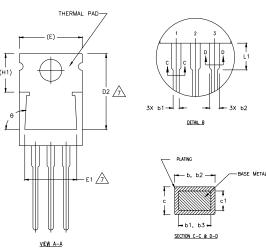


Fig 23b. Gate Charge Waveform

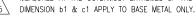
## TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.
- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.



- CONTROLLING DIMENSION: INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED.

		DIMEN	SIONS		
SYMBOL	MILLIM	ETERS	INC	HES	
	MIN.	MAX.	MIN.	MAX.	NOTES
Α	3.56	4.82	.140	.190	
A1	0.51	1.40	.020	.055	
A2	2.04	2.92	.080	.115	
b	0.38	1.01	.015	.040	
ь1	0.38	0.96	.015	.038	5
b2	1.15	1.77	.045	.070	
b3	1.15	1.73	.045	.068	
С	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	12.19	12.88	.480	.507	7
E	9.66	10.66	.380	.420	4,7
E1	8.38	8.89	.330	.350	7
е	2.54	BSC	.100	BSC	
e1	5.	08	.200	BSC	
Н1	5.85	6.55	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	-	6.35	-	.250	3
øΡ	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	
ø	90°-	-93°	90°	-93°	

### LEAD ASSIGNMENTS

### HEXFET

1.- GATE 2.- DRAIN 3.- SOURCE

### IGBTs, CoPACK

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE/OPEN 2.- CATHODE 3.- ANODE

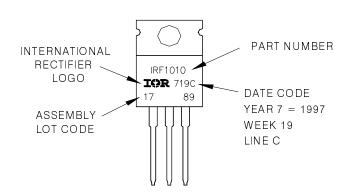
# TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010

LOT CODE 1789

ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead-Free"



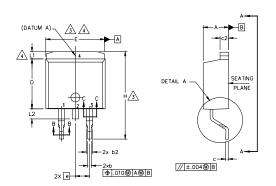
TO-220AB packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

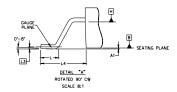
8 www.irf.com

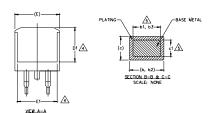
# D<sup>2</sup>Pak (TO-263AB) Package Outline

Dimensions are shown in millimeters (inches)









### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

O.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB

S		DIMENSIONS					
M B O	MILLIM	ETERS	INC	HES	O T E S		
L	MIN.	MAX.	MIN.	MAX.	S		
Α	4.06	4.83	.160	.190			
A1	0.00	0.254	.000	.010			
ь	0.51	0.99	.020	.039			
ь1	0.51	0.89	.020	.035	5		
b2	1,14	1.78	.045	.070			
b3	1.14	1.73	.045	.068	5		
С	0.38	0.74	.015	.029			
c1	0.38	0.58	.015	.023	5		
c2	1.14	1.65	.045	.065			
D	8.38	9.65	.330	.380	3		
D1	6.86	-	.270		4		
E	9.65	10.67	.380	.420	3,4		
E1	6.22	-	.245		4		
e	2.54	BSC	.100	BSC			
н	14.61	15.88	.575	.625			
L	1.78	2.79	.070	.110			
L1	-	1.65	-	.066	4		
L2	1.27	1.78	-	.070			
L3	0.25	BSC	.010	.010 BSC			
L4	4.78	5.28	.188	.208			

### LEAD ASSIGNMENTS

### HEXFET

1.- GATE 2, 4.- DRAIN 3.- SOURCE

### IGBTs, CoPACK

1.- GATE
2, 4.- COLLECTOR
3.- EMITTER

### DIODES

1.- ANODE \*
2. 4.- CATHODE
3.- ANODE

\* PART DEPENDENT.

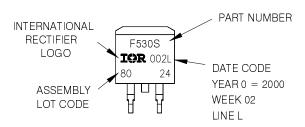
# D<sup>2</sup>Pak (TO-263AB) Part Marking Information

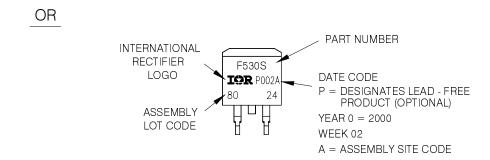
EXAMPLE: THIS IS AN IRF530S WITH

LOT CODE 8024

ASSEMBLED ON WW 02, 2000 IN THE ASSEMBLY LINE "L"

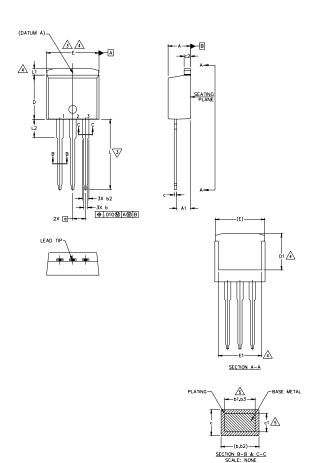
Note: "P" in assembly line position indicates "Lead — Free"





# TO-262 Package Outline

Dimensions are shown in millimeters (inches)



- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED  $^{\circ}$ 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.— OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(max.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

S Y M B		Ŋ			
B	MILLIM	ETERS	INC	HES	N O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
b	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1,14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1,14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	-	.270	-	4
Ε	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245		4
e	2.54	BSC	.100 BSC		
L	13.46	14.10	.530	.555	
L1	-	1.65	-	.065	4
L2	3.56	3.71	.140	.146	

### LEAD ASSIGNMENTS

### HEXFET

- 1 GATE 2.- DRAIN
- 3.- SOURCE
- 4.- DRAIN

### IGBTs, CoPACK

- 1.- GATE
  2.- COLLECTOR
  3.- EMITTER
  4.- COLLECTOR

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# TO-262 Part Marking Information

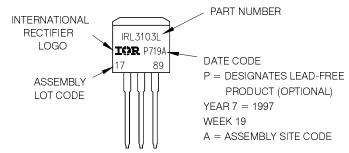
EXAMPLE: THIS IS AN IRL3103L LOT CODE 1789

ASSEMBLED ON WW 19, 1997 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position indicates "Lead - Free"

PART NUMBER INTERNATIONAL **RECTIFIER** IRL3103L LOGO **IOR** 719C DATE CODE 89 YEAR 7 = 1997 **ASSEMBLY** WEEK 19 LOT CODE LINE C

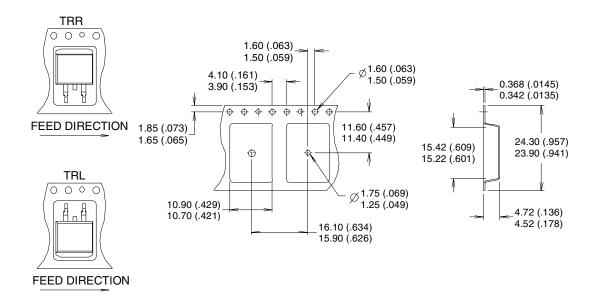
OR

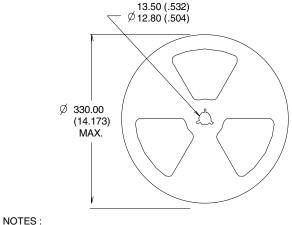


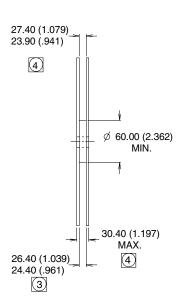
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

# D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information

Dimensions are shown in millimeters (inches)







1. COMFORMS TO EIA-418.

2. CONTROLLING DIMENSION: MILLIMETER.

3 DIMENSION MEASURED @ HUB.

4 INCLUDES FLANGE DISTORTION @ OUTER EDGE.

Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>

Data and specifications subject to change without notice. This product has been designed and qualified for the Industrial market.

Qualification Standards can be found on IR's Web site.



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